Application/Control No. Applicant(s)/Patent Under Reexamination 10/018,686 ONISHI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Michael V. Battaglia 2627 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY * 09-2002 US-6,449,225 Alon, Amir 369/44.17 Α US-В US-С US-D US-E US-F US-G US-Н US-US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS Date **Document Number** Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) υ

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